

PSMN9R5-100XS

N-channel 100V 9.6 m Ω standard level MOSFET in TO220F (SOT186A)

Rev. 2 — 20 October 2011

Preliminary data sheet

1. Product profile

1.1 General description

Standard level N-channel MOSFET in TO220F (SOT186A) package qualified to 175C. This product is designed and qualified for use in a wide range of industrial, communications and domestic equipment.

1.2 Features and benefits

- High efficiency due to low switching and conduction losses
- Isolated package
- Suitable for standard level gate drive

1.3 Applications

- AC-to-DC power supply equipment
- Motor control

- Server power supplies
- Synchronous rectification

1.4 Quick reference data

Table 1. Quick reference data

Symbol	Parameter	Conditions	Min	Тур	Max	Unit
V_{DS}	drain-source voltage	$T_j \ge 25 \text{ °C}; T_j \le 175 \text{ °C}$	-	-	100	V
I _D	drain current	T_{mb} = 25 °C; V_{GS} = 10 V; see <u>Figure 1</u>	-	-	44.2	Α
P _{tot}	total power dissipation	T _{mb} = 25 °C; see <u>Figure 2</u>	-	-	52.6	W
Static charac	teristics					
R _{DSon}	drain-source on-state resistance	$V_{GS} = 10 \text{ V}; I_D = 10 \text{ A};$ $T_j = 25 \text{ °C}; \text{ see } \frac{\text{Figure 12}}{\text{see } \frac{\text{Figure 13}}{\text{Figure 13}}}$	-	8.15	9.6	mΩ
Dynamic cha	racteristics					
Q_{GD}	gate-drain charge	$V_{GS} = 10 \text{ V}; I_D = 10 \text{ A};$	-	24.3	-	nC
Q _{G(tot)}	total gate charge	V _{DS} = 50 V; see <u>Figure 14;</u> see <u>Figure 15</u>	-	81.5	-	nC
Avalanche ru	ggedness					
E _{DS(AL)S}	non-repetitive drain-source avalanche energy	$\begin{split} &V_{GS} = 10 \text{ V; } T_{j(init)} = 25 \text{ °C;} \\ &I_D = 44.2 \text{ A; } V_{sup} \leq 100 \text{ V;} \\ &unclamped R_{GS} = 50 \Omega; \\ &see \underline{Figure 3} \end{split}$	-	-	260	mJ



2. Pinning information

Table 2. Pinning information

Pin	Symbol	Description	Simplified outline	Graphic symbol
1	G	gate		_
2	D	drain	mb	D
3	S	source		$G \longrightarrow A$
mb		mounting base; isolated		mbb076 S
			SOT186A (TO-220F)	

3. Ordering information

Table 3. Ordering information

Type number	Package	Package			
	Name	Description	Version		
PSMN9R5-100XS	TO-220F	plastic single-ended package; isolated heatsink mounted; 1 mounting hole; 3-lead TO-220 "full pack"	SOT186A		

4. Limiting values

Table 4. Limiting values

In accordance with the Absolute Maximum Rating System (IEC 60134).

Symbol	Parameter	Conditions	Min	Max	Unit
V_{DS}	drain-source voltage	T _j ≥ 25 °C; T _j ≤ 175 °C	-	100	V
V_{DGR}	drain-gate voltage	$T_j \ge 25$ °C; $T_j \le 175$ °C; $R_{GS} = 20$ kΩ	-	100	V
V_{GS}	gate-source voltage		-20	20	V
I _D	drain current	$V_{GS} = 10 \text{ V; } T_{mb} = 25 \text{ °C; see } \frac{\text{Figure 1}}{\text{Model}}$	-	44.2	Α
		$V_{GS} = 10 \text{ V; } T_{mb} = 100 \text{ °C; see } \frac{\text{Figure 1}}{}$	-	31.3	Α
I _{DM}	peak drain current	pulsed; $t_p \le 10 \mu s$; $T_{mb} = 25 ^{\circ}C$; see Figure 4	-	177	Α
P _{tot}	total power dissipation	T _{mb} = 25 °C; see <u>Figure 2</u>	-	52.6	W
T _{stg}	storage temperature		-55	175	°C
Tj	junction temperature		-55	175	°C
T _{sld(M)}	peak soldering temperature		-	260	°C
Source-drai	in diode				
Is	source current	T _{mb} = 25 °C	-	43.8	Α
I _{SM}	peak source current	pulsed; $t_p \le 10 \ \mu s$; $T_{mb} = 25 \ ^{\circ}C$	-	177	Α
Avalanche i	ruggedness				
E _{DS(AL)S}	non-repetitive drain-source avalanche energy	V_{GS} = 10 V; $T_{j(init)}$ = 25 °C; I_D = 44.2 A; $V_{sup} \le$ 100 V; unclamped; R_{GS} = 50 Ω ; see Figure 3	-	260	mJ

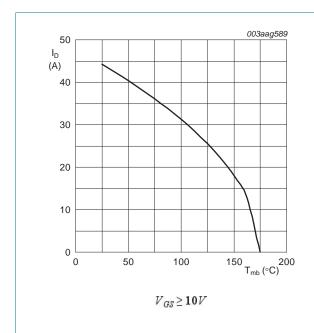


Fig 1. Continuous drain current as a function of mounting base temperature

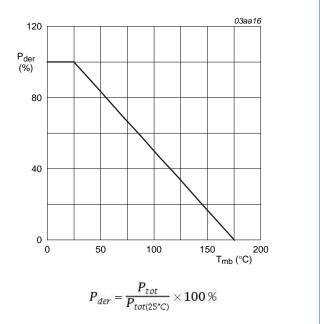


Fig 2. Normalized total power dissipation as a function of mounting base temperature

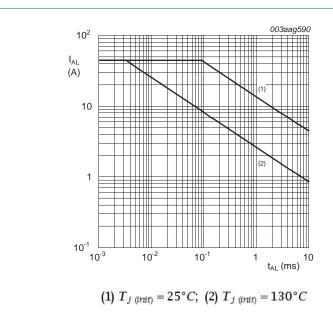
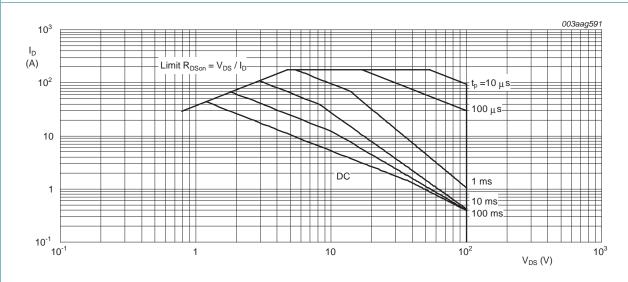


Fig 3. Single pulse avalanche rating; avalanche current as a function of avalanche time



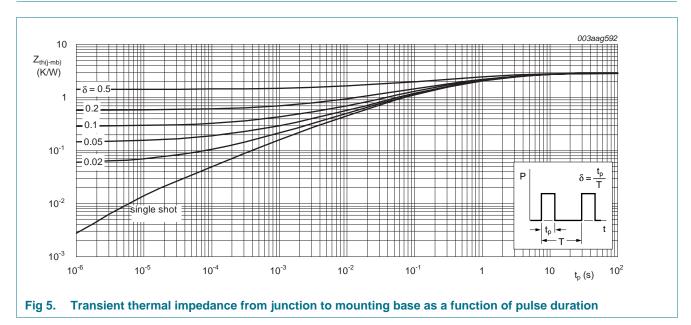
 $T_{mb} = 25^{\circ}C$; I_{DM} is a single pulse

Fig 4. Safe operating area; continuous and peak drain currents as a function of drain-source voltage

5. Thermal characteristics

Table 5. Thermal characteristics

Symbol	Parameter	Conditions	Min	Тур	Max	Unit
R _{th(j-mb)}	thermal resistance from junction to mounting base	see Figure 5	-	2.6	2.85	K/W
R _{th(j-a)}	thermal resistance from junction to ambient	vertical in free air	-	55	-	K/W



6. Isolation characteristics

Table 6. Isolation characteristics

Symbol	Parameter	Conditions		Min	Тур	Max	Unit
C _{isol}	isolation capacitance		[1]	-	10	-	pF
$V_{\text{isol}(\text{RMS})}$	RMS isolation voltage	50 Hz ≤ f ≤ 60 Hz; RH ≤ 65 %; sinusoidal waveform; clean and dust free		-	-	2500	V

[1] f = 1 MHz

7. Characteristics

Table 7. Characteristics

Symbol	Parameter	Conditions	Min	Tyre	Max	Unit
Symbol	racteristics	Conditions	IVIII	Тур	IVIAX	Unit
		1 050 A W 0 V T 05 00	400			
$V_{(BR)DSS}$	drain-source breakdown voltage	$I_D = 250 \mu A; V_{GS} = 0 V; T_j = 25 °C$	100	-	-	V
		$I_D = 250 \mu A; V_{GS} = 0 V; T_j = -55 ^{\circ}C$	90	-	-	V
$V_{GS(th)}$	gate-source threshold voltage	$I_D = 1 \text{ mA}$; $V_{DS} = V_{GS}$; $T_j = 25 \text{ °C}$; see <u>Figure 10</u> ; see <u>Figure 11</u>	2	3	4	V
		$I_D = 1$ mA; $V_{DS} = V_{GS}$; $T_j = 175$ °C; see Figure 10	1	-	-	V
		$I_D = 1 \text{ mA}$; $V_{DS} = V_{GS}$; $T_j = -55 \text{ °C}$; see Figure 10	-	-	4.6	V
I _{DSS}	drain leakage current	$V_{DS} = 100 \text{ V}; V_{GS} = 0 \text{ V}; T_j = 25 \text{ °C}$	-	-	4	μA
		$V_{DS} = 100 \text{ V}; V_{GS} = 0 \text{ V}; T_j = 100 ^{\circ}\text{C}$	-	-	80	μA
I _{GSS}	gate leakage current	$V_{GS} = 20 \text{ V}; V_{DS} = 0 \text{ V}; T_i = 25 \text{ °C}$	-	2	100	nA
		V _{GS} = -20 V; V _{DS} = 0 V; T _j = 25 °C	-	2	100	nA
R _{DSon}	drain-source on-state resistance	$V_{GS} = 10 \text{ V}; I_D = 10 \text{ A}; T_j = 25 \text{ °C};$ see Figure 12; see Figure 13	-	8.15	9.6	mΩ
		$V_{GS} = 10 \text{ V}; I_D = 10 \text{ A}; T_j = 100 \text{ °C};$ see Figure 13	-	14.25	16.8	mΩ
		$V_{GS} = 10 \text{ V}; I_D = 10 \text{ A}; T_j = 175 ^{\circ}\text{C};$ see Figure 13	-	22.8	26.9	mΩ
R _G	internal gate resistance (AC)	f = 1 MHz	-	0.7	-	Ω
Dynamic	characteristics					
Q _{G(tot)}	total gate charge	$I_D = 10 \text{ A}; V_{DS} = 50 \text{ V}; V_{GS} = 10 \text{ V};$	-	81.5	-	nC
Q _{GS}	gate-source charge	see Figure 14; see Figure 15	-	15.6	-	nC
Q _{GS(th)}	pre-threshold gate-source charge		-	11.9	-	nC
Q _{GS(th-pl)}	post-threshold gate-source charge		-	3.7	-	nC
Q_{GD}	gate-drain charge		-	24.3	-	nC
$V_{GS(pl)}$	gate-source plateau voltage	$I_D = 10 \text{ A}$; $V_{DS} = 50 \text{ V}$; see <u>Figure 14</u> ; see <u>Figure 15</u>	-	4	-	V
C _{iss}	input capacitance	$V_{DS} = 50 \text{ V}; V_{GS} = 0 \text{ V}; f = 1 \text{ MHz};$ $T_j = 25 \text{ °C}; \text{ see } \frac{\text{Figure 16}}{\text{Figure 17}};$ see Figure 17	-	4454	-	pF
C _{oss}	output capacitance	$V_{DS} = 50 \text{ V}; V_{GS} = 0 \text{ V}; f = 1 \text{ MHz};$ $T_j = 25 \text{ °C}; \text{ see } \frac{\text{Figure 16}}{\text{ or } 100 \text{ cm}}$	-	302	-	pF
C _{rss}	reverse transfer capacitance	$V_{DS} = 50 \text{ V}; V_{GS} = 0 \text{ V}; f = 1 \text{ MHz};$ $T_j = 25 \text{ °C}; \text{ see } \frac{\text{Figure 16}}{\text{Figure 17}};$ see Figure 17	-	185	-	pF
t _{d(on)}	turn-on delay time	$V_{DS} = 50 \text{ V}; R_L = 5 \Omega; V_{GS} = 10 \text{ V};$	-	21	-	ns
t _r	rise time	$R_{G(ext)} = 4.7 \Omega$; $T_j = 25 °C$	-	22	-	ns
t _{d(off)}	turn-off delay time		-	68	-	ns
t _f	fall time		-	33	-	ns

Table 7. Characteristics ... continued

Symbol	Parameter	Conditions	Min	Тур	Max	Unit
Source-dra	in diode					
V_{SD}	source-drain voltage	$I_S = 10 \text{ A}; V_{GS} = 0 \text{ V}; T_j = 25 ^{\circ}\text{C};$ see <u>Figure 18</u>	-	0.76	1.2	V
t _{rr}	reverse recovery time	$I_S = 10 \text{ A}$; $dI_S/dt = -100 \text{ A/}\mu\text{s}$;	-	61.5	-	ns
Q _r	recovered charge	$V_{GS} = 0 \text{ V}; V_{DS} = 50 \text{ V}$	-	157	-	nC

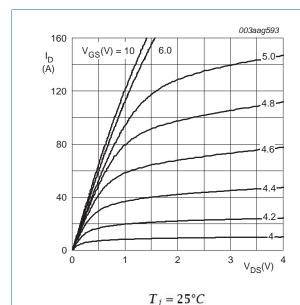


Fig 6. Output characteristics; drain current as a function of drain-source voltage; typical values

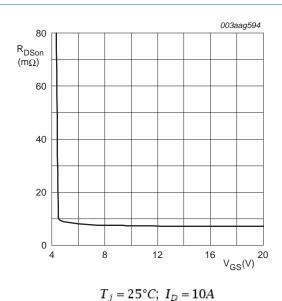


Fig 7. Drain-source on-state resistance as a function of gate-source voltage; typical values

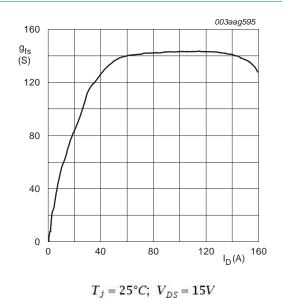


Fig 8. Forward transconductance as a function of drain current; typical values

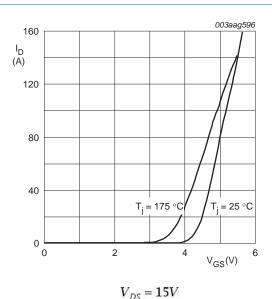
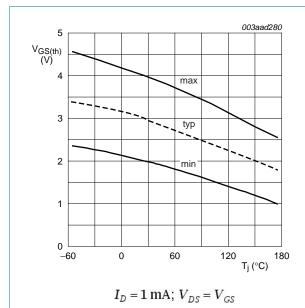
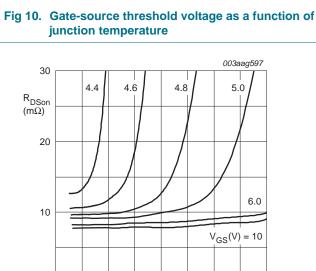


Fig 9. Transfer characteristics; drain current as a function of gate-source voltage; typical values



junction temperature



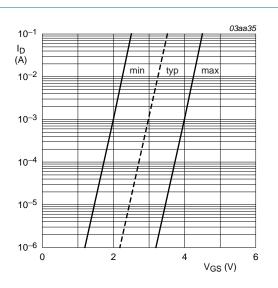
40

Fig 12. Drain-source on-state resistance as a function of drain current; typical values

80

 $T_j = 25^{\circ}C$

I_D(A) 160



 $T_j = 25 \,^{\circ}C; V_{DS} = 5V$

Fig 11. Sub-threshold drain current as a function of gate-source voltage

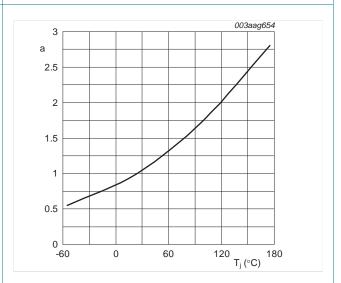
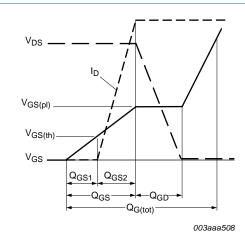


Fig 13. Normalized drain-source on-state resistance factor as a function of junction temperature

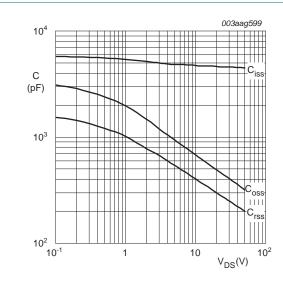


10 003aag598 (V) 8 8 80V 6 V_{DS}= 20V 40 60 80 100 Q_G (nC)

 $T_j = 25^{\circ}C; \ I_D = 10A$

Fig 14. Gate charge waveform definitions





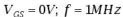
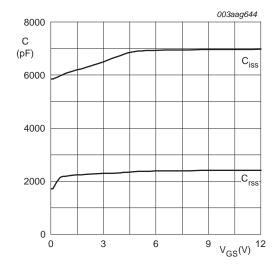
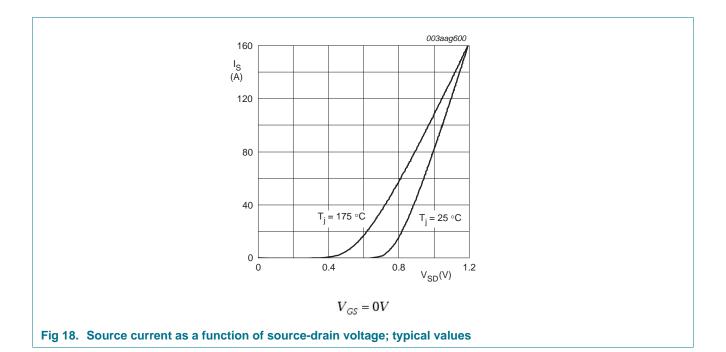


Fig 16. Input, output and reverse transfer capacitances as a function of drain-source voltage; typical values



f = 1MHz, $V_{DS} = 0V$

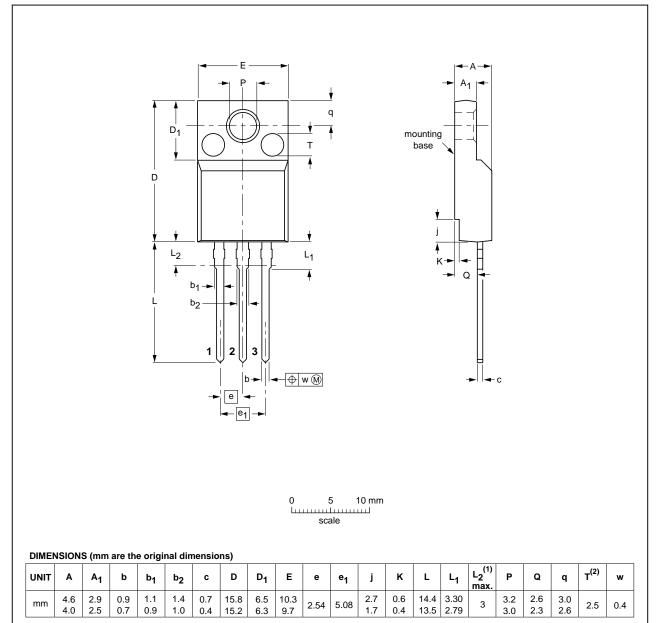
Fig 17. Input and reverse transfer capacitances as a function of gate-source voltage, typical values



8. Package outline

Plastic single-ended package; isolated heatsink mounted; 1 mounting hole; 3-lead TO-220 'full pack'

SOT186A



Notes

- 1. Terminal dimensions within this zone are uncontrolled.
- 2. Both recesses are \varnothing 2.5 \times 0.8 max. depth

OUTLINE		REFER	ENCES		EUROPEAN	ISSUE DATE
VERSION	IEC	JEDEC	DEC JEITA PROJ		PROJECTION	ISSUE DATE
SOT186A		3-lead TO-220F				-02-04-09 06-02-14

Fig 19. Package outline SOT186A (TO-220F)

PSMN9R5-100XS

9. Revision history

Table 8. Revision history

Document ID	Release date	Data sheet status	Change notice	Supersedes		
PSMN9R5-100XS v.2	20111020	Preliminary data sheet	-	PSMN9R5-100XS v.1		
Modifications:	Status changed from objective to preliminary. • Status changed from objective to preliminary.					
	 Various changes to 	content.				
PSMN9R5-100XS v.1	20110721	Objective data sheet	-	-		

10. Legal information

10.1 Data sheet status

Document status [1] [2]	Product status [3]	Definition
Objective [short] data sheet	Development	This document contains data from the objective specification for product development.
Preliminary [short] data sheet	Qualification	This document contains data from the preliminary specification.
Product [short] data sheet	Production	This document contains the product specification.

- [1] Please consult the most recently issued document before initiating or completing a design.
- [2] The term 'short data sheet' is explained in section "Definitions"
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PSMN9R5-100XS

PSMN9R5-100XS

N-channel 100V 9.6 mΩ standard level MOSFET in TO220F (SOT186A)

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